

About 70 experimental stations are operated at the PF Storage Ring and the PF-AR, as shown in Figs. 1 and 2. Two thirds of the stations are dedicated to research using hard X-rays, with the remaining one third used for studies in the VUV and soft X-ray energy regions. Tables 1 and 2 summarize the areas of the research carried out at experimental stations at the PF storage ring and PF-AR.

The specifications in terms of optics and performance of each experimental station differ according to experimental requirements and methodology. Tables 3 and 4 list the details of the optics of the hard X-ray stations and the soft X-ray / VUV stations. The principal performance parameters, including energy range, energy resolution, beam-spot size, and photon flux at the sample position are shown.

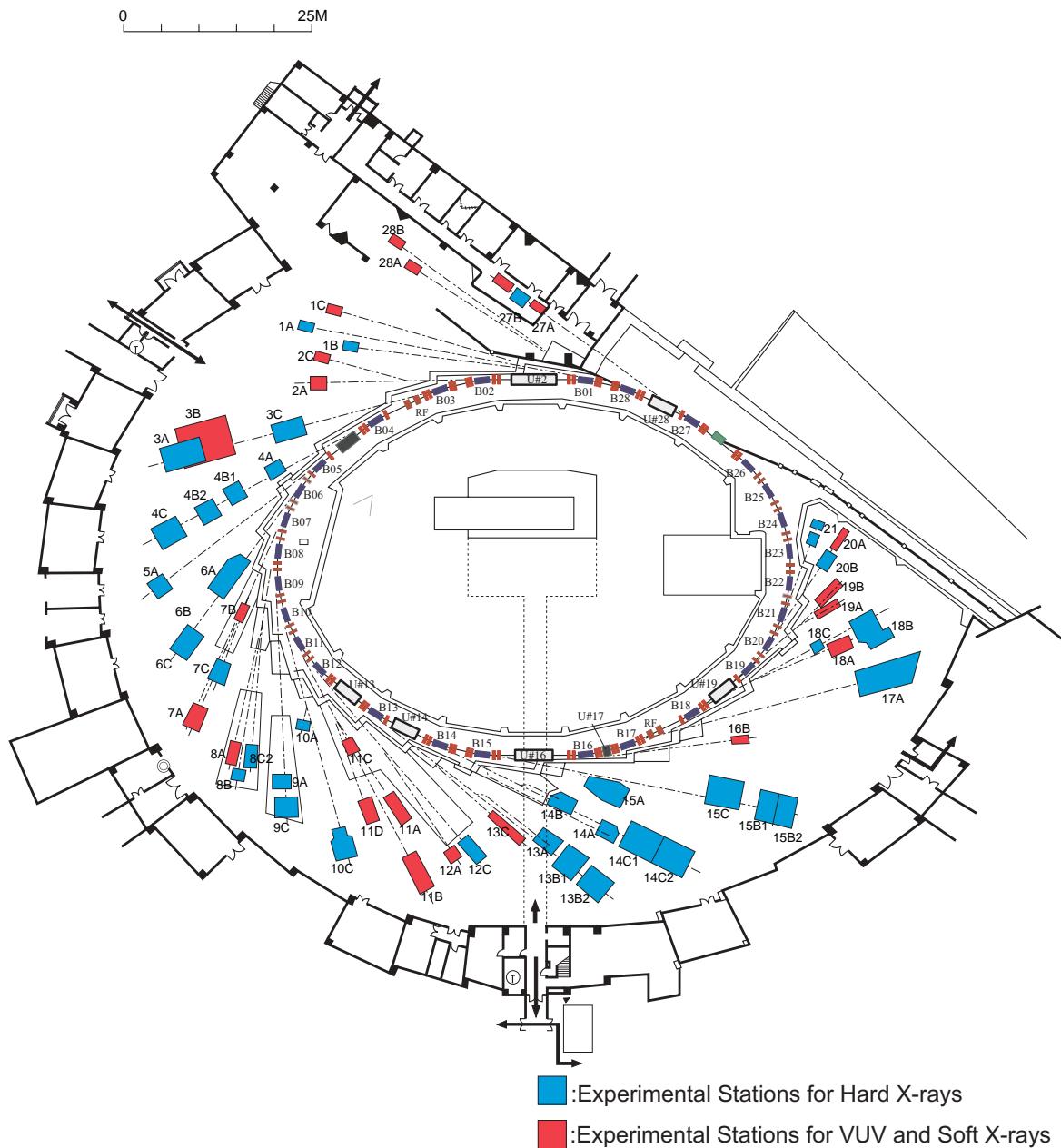


Figure 1

Plan view of the PF experimental hall, showing hard X-ray experimental stations (blue), and VUV and soft X-ray experimental stations (red).

Table 1 Complete list of experimental stations at the PF Storage Ring.

Experimental Station		Spokesperson
BL-1		
A	Crystal structure analysis beamline	H. Sawa
B	X-ray powder diffraction under extreme condition	H. Sawa
C	VUV and soft X-ray photoelectron spectroscopy	K. Ono
BL-2	(Undulator)	
A	Soft X-ray spectroscopy	Y. Kitajima
C	Soft X-ray spectroscopy	A. Yagishita
BL-3		
A***	X-ray diffraction and scattering station for materials science	Y. Wakabayashi
A*	X-ray diffraction and scattering	T. Iwazumi
B	VUV and soft X-ray spectroscopy	Y. Azuma
C	Characterization of X-ray optical elements/White X-ray magnetic diffraction	H. Adachi
C2**	Characterization of X-ray optical elements	X. Zhang
C3***	X-ray magnetic Bragg scattering by means of white X-rays	H. Adachi
BL-4		
A	Trace element analysis, X-ray microprobe	A. Iida
B1	Micro-crystal and Micro-area structure analysis	A. Nakao
B2	Powder diffraction	A. Nakao
C	X-ray diffraction and scattering	Y. Wakabayashi
BL-5	(Multipole Wiggler)	
A	Macromolecular crystallography	Y. Yamada
BL-6		
A	Macromolecular crystallography	N. Igarashi
C***	X-ray diffraction and scattering	H. Sawa
BL-7		
A	[RCS] Soft X-ray spectroscopy	H. Kondo [RCS], K. Amemiya
B	[RCS] Surface photochemical reaction and angle-resolved photoelectron spectroscopy	H. Kondo [RCS], K. Amemiya
C	X-ray spectroscopy and diffraction	T. Iwazumi
BL-8		
A	Soft X-ray spectroscopy	K. Mase
B	EXAFS	K. Mase
C	X-ray tomography and X-ray microscopy	K. Hirano
BL-9		
A	XAES	Y. Inada
C	X-ray versatile station	M. Nomura
BL-10		
A	X-ray diffraction/scattering	A. Nakao
C	Small-angle X-ray scattering of solution sample	K. Kobayashi
BL-11		
A	Soft X-ray spectroscopy	Y. Kitajima
B	Surface EXAFS, soft X-ray spectroscopy	Y. Kitajima
C	VUV spectroscopy (solid state)	K. Ono
D	VUV and soft X-ray photoelectron spectroscopy for solid	K. Ito
BL-12		
A	Characterization of VUV-SX optical elements, soft X-ray spectroscopy	A. Yagishita
C	XAES	M. Nomura

Experimental Station		Spokesperson
BL-13	(Multipole Wiggler/Undulator)	
A	Laser-heating high-pressure and high-temperature X-ray diffraction (DAC)	T. Kikegawa
B1	Surface-sensitive XAFS, X-ray diffraction	T. Kikegawa
B2	High-pressure and high-temperature X-ray diffraction	T. Kikegawa
C	Soft X-ray photoemission spectroscopy and XAFS	K. Mase
BL-14	(Vertical Wiggler)	
A	Crystal structure analysis and detector development	S. Kishimoto
B	High-precision X-ray optics	K. Hirano
C1	Medical applications and X-ray experiments for general purpose	K. Hyodo
C2	High-pressure and high-temperature X-ray diffraction (MAX-III)	T. Kikegawa
BL-15		
A	Small-angle X-ray scattering of muscle and alloys	R. Kato
B1	White X-ray topography and X-ray experiments for general purpose	H. Sugiyama
B2	Surface and interface X-ray diffraction	H. Sugiyama
C	High-resolution X-ray diffraction	K. Hirano
BL-16	(Multipole Wiggler/Undulator)	
A1*	General purpose (X-ray)	Y. Wakabayashi
A2*	X-ray diffraction and scattering	Y. Wakabayashi
B	Soft X-ray spectroscopy	J. Adachi
BL-17		
A	Macromolecular crystallography	N. Igarashi
BL-18		
A	[ISSP] Angle-resolved photoelectron spectroscopy of surfaces and interfaces	A. Kakizaki [ISSP], A. Yagishita
B	General purpose (X-ray)	A. Iida
C	High pressure X-ray powder diffraction (DAC)	T. Kikegawa
BL-19	(Revolver Undulator)	
A	[ISSP] Spin-resolved photoelectron spectroscopy (Mott detector)	A. Kakizaki [ISSP], A. Yagishita
B	[ISSP] Soft X-ray emission spectroscopy	S. Shin [ISSP], A. Yagishita
BL-20		
A	VUV spectroscopy	K. Ito
B	[ANBF] White and monochromatic beam general-purpose X-ray station	G. Foran [ANBF], H. Kawata
BL-21	[Light Source Division] Beam position monitoring	K. Haga [Light Source]
BL-27	(Beamline for experiments using radioisotopes)	
A	Radiation biology, soft X-ray photoelectron spectroscopy	K. Kobayashi
B	Radiation biology, XAFS, X-ray diffuse scattering	N. Usami
BL-28	(Elliptical / Helical Undulator)	
A	High-resolution VUV-SX beamline for angle-resolved photoemission	K. Ono
B***	High-resolution VUV-SX spectroscopy	K. Ono

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* shutdown at the summer of 2006.

** renovated to new BL-3C at the summer of 2006.

*** set up at the 2006.

Table 2 List of experimental stations at the PF-AR.

Experimental Station		Spokesperson
AR-NE1 (Elliptical Multipole Wiggler / Helical Undulator)		
A1 High-resolution Compton and magnetic Compton scattering		H. Kawata
A2 Coronary angiography		K. Hyodo
B Spectroscopy with circularly polarized soft X-rays		T. Koide
AR-NE3 (Undulator)		
A Nuclear resonant scattering		X. Zhang
AR-NE5		
A Medical applications and X-ray experiments for general purpose		K. Hyodo
B Bunch-purity and beam-position monitoring		S. Kishimoto
C High pressure and high temperature X-ray diffraction (MAX-80)		T. Kikegawa
AR-NW2 (Undulator)		
A XAFS/Dispersive XAFS /Time-resolved-X-ray diffraction		Y. Inada
AR-NW10		
A XAFS		M. Nomura
AR-NW12 (Undulator)		
A Macromolecular crystallography		N. Matsugaki
AR-NW14 (Undulator)		
A Time-resolved X-ray diffraction, scattering and absorption		S. Koshihara [ERATO], S. Adachi

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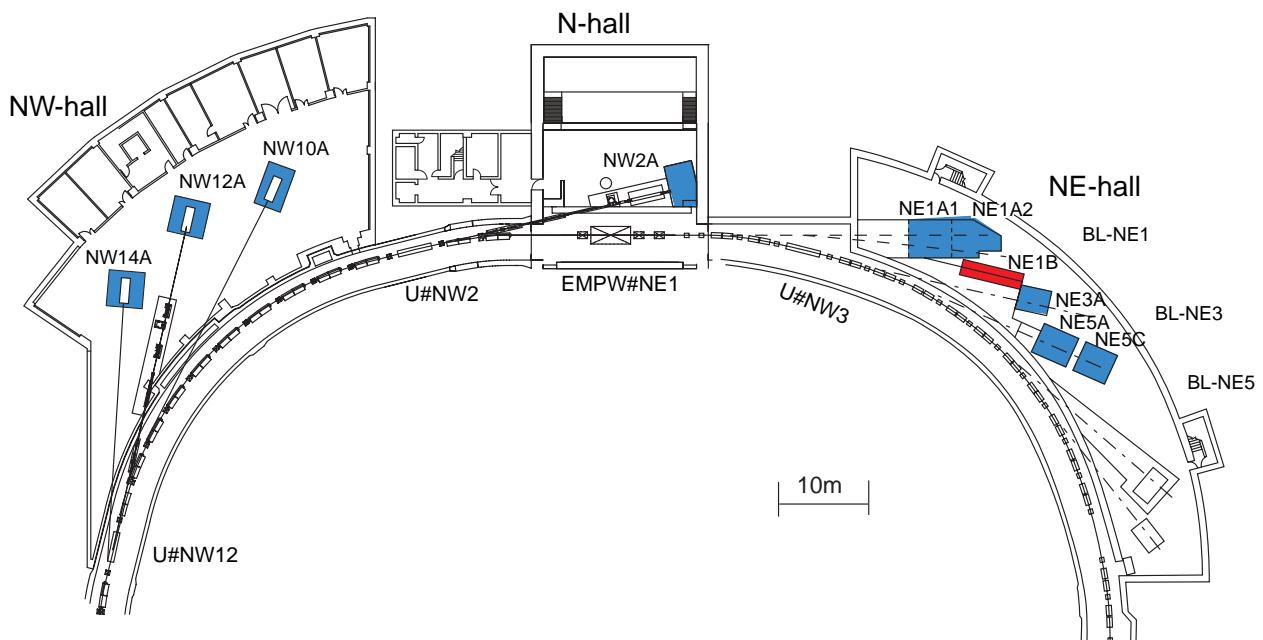


Figure 2
Plan view of beamlines in the PF-AR north-east, north, and north-west experimental halls.

Table 3 Specifications of X-ray beamline optics.

Branch Beamline	Horizontal Acceptance (mrad)	Type of Monochromator	Mirror	Photon Energy (keV)	Beam Size (HxV) (mm)	Photon Flux at Sample Position (/s)	Energy Resolution ($\Delta E/E \times 10^{-4}$)	Reference
BL-1A		Flat Double Crystal Si(111)	Bent Cylinder	5 ~ 20	0.7x0.3	4x10 ¹¹ (8.3 keV, 400 mA)	~ 5	
BL-1B	2	Flat Double Crystal Si(111)	Bent Cylinder	6 ~ 21	0.7x0.5	8x10 ¹⁰ /4mm ² (8.3 keV, 300 mA)	~ 5	1
BL-3A***	1	Flat Double Crystal Si(111)	Bent Cylinder	4 ~ 14	0.7x0.2	6x10 ¹²	~ 5	
BL-3A*	4	Double Crystal Si(111) Sagittal Focusing	Collimating Focusing Mirrors (Fused Quartz)	6 ~ 20	100x5 2x1		~ 2	2-4
BL-3C	1.75	Double Crystal Si(111)	None	4 ~ 20 or white	20x6(mono) 0.1x0.1(white)			
BL-3C2**	2	Double Crystal Si(111), Si(311)	None	4 ~ 20 6 ~ 34	5x2	1x10 ¹⁰ 2x10 ⁹		
BL-3C3**	2	Double Crystal Si(111)	None	5 ~ 30 or white	20x4 0.1x0.1			
BL-4A	6	Double Crystal Sagittal Focusing	Vertical Focusing Mirror	4 ~ 20	50x4 4x1		~ 2	5
BL-4B1	4.5	Double Crystal Si(111)	None	4 ~ 35	50x5		~ 2	6
BL-4B2	4.5	Double Crystal Si(111)	Bent Cylinder	6 ~ 20	13x2		~2	7, 8
BL-4C	2	Flat Double Crystal Si (111)	Bent Cylinder	5 ~ 19	0.7x0.5		~5	9, 10
BL-5A	2	Micro-Channel Double Crystal Si(111)	Bent Plane Si Rh-Coated Bent Cylinder Si Rh-Coated	6.5 ~ 17	1.2x0.4	6.6x10 ¹¹ (12.7keV, 450mA, 0.2x0.2 mm ²)	~2	
BL-6A	1.2	Bent Si(111) ($\alpha = 7.5^\circ$)	Bent Plane ULE	9.5 ~ 13.5	0.5x0.25 (12.7keV)	1x10 ¹⁰ (12.7keV, 450mA, 0.2x0.2 mm ²)	~10	11
BL-6C***	2	Flat Double Crystal Si(111)	Bent Cylinder	5 ~ 12 (~25 non-Focus)	1.2x1.2			
BL-7C	4	Double Crystal Si (111) Sagittal Focusing	Double Mirror Fused Quartz Focusing	4 ~ 20 (4 ~ 13)	5x1	1x10 ¹⁰ /6mm ² (8 keV, 300 mA) (1x10 ¹¹ when focused)	~ 2	12 - 14

Branch Beamline	Horizontal Acceptance (mrad)	Type of Monochromator	Mirror	Photon Energy (keV)	Beam Size (HxV) (mm)	Photon Flux at Sample Position (/s)	Energy Resolution ($\Delta E/E \times 10^{-4}$)	Reference
BL-8C	5	Channel-Cut Si(220), Si(111), Si(400)	None	5 ~ 40	50x5	6x10 ⁸ /mm ² (10 keV, 300 mA)	~ 2	
BL-9A	3	Double Crystal Si (111)	Collimating and Focusing Bent Conical Mirrors (Rh-Coated) Double Flat Mirror (Rh/Ni-Coated)	2.2 ~ 15	1x0.3	4x10 ¹¹ (9 keV, 300 mA)	2	15, 16
BL-9C	3.5	Double Crystal Si(111)	Bent Cylinder Rh-Coated Si	4 ~ 23 or white	1x1	5x10 ¹⁰ (9 keV, 300 mA)	~ 2	
BL-10A	1	Si(111), Si(311) Quartz(100), PG(002) Curved Si(111) ($\alpha \sim 4^\circ, 8^\circ$)	Plane Pt coated Fused Quartz	5 ~ 25	10x3		10 ~ 5	17
BL-10C	4	Double Crystal Si(111)	Bent Cylinder	4 ~ 10	1.2x0.2	$\sim 10^{11}/1.5\text{mm}^2$ (8 keV, 400 mA)	2	
BL-12C	2	Double Crystal Si(111) Si(311)	Bent Cylinder	6 ~ 23	0.65x0.4	5x10 ¹⁰ /1mm ² (8 keV, 300mA) w.Si(111)	~ 2	18
BL-13A	1	Double Crystal Si(111), Ge(111)	Cylinder Pt-coat Fused Quartz	30	0.045x0.032	5x10 ¹⁰ /1mm ²	~ 2	19
BL-13B1 B2	4	Double Crystal Si(111), Si(220) Sagittal Focusing	Bent Plane Fused Quartz	4 ~ 30	4x1		~ 2	20
BL-14A	1.28 (Vertical)	Double Crystal Si (111) Si (311) Si (553)	Bent Cylinder Rh-coated Fused Quartz	5.1 ~ 19.1 9.9 ~ 35.6 22.7 ~ 84.5	2x1 at focus 5x38		2	21
BL-14B	2.2 (Vertical)	Double Crystal Si(111),	None	10 ~ 57	5x14		2	
BL-14C1 C2	1.96 (Vertical)	Double Crystal Si(111), Si(220)	None	5 ~ 100 or white	6x70		2	22, 23
BL-15A	2	Bent Crystal Ge(111) ($\alpha = 8.0^\circ$)	Bent Plane, Fused Quartz Pt-coated	8.0 (fixed)	0.5x0.25	9x10 ¹⁰ /mm ² (8.0 keV, 350 mA)	~ 10	24
BL-15B1 B2	2	Double Crystal Si (111)	Bent Cylinder	5 ~ 20 or white	0.6x0.4	10 ¹¹ /1mm ² (8.0keV, 350mA)	~ 2	
BL-15C	2	Double Crystal Si (111)	None	4 ~ 30	60x6			

Branch Beamline	Horizontal Acceptance (mrad)	Type of Monochromator	Mirror	Photon Energy (keV)	Beam Size (HxV) (mm)	Photon Flux at Sample Position (/s)	Energy Resolution ($\Delta E/E \times 10^{-4}$)	Reference
BL-16A1 A2	1	Double Crystal Si(111) Sagittal Focusing	Bent Plane (Rh on Si) and Bent Plane (Rh on SiC)	4 ~ 25	1.2x0.5	$\sim 1 \times 10^{13}$ (8.3 keV, 300 mA)	~ 1	25
BL-17A	0.1 ~ 0.2	Double Crystal Si(111) Liquid N ₂ cooling	Bent Plane Si Rh-Coated Bent Plane Si Rh-Coated	6 ~ 9 11 ~ 13	0.25x0.04	10^{10} (12.4 keV, 450mA, 0.02x0.02mm ²)	~ 2	26
BL-18B	2	Double Crystal Si(111)	Plane and Bent Cylinder	6 ~ 30			~ 2	
BL-18C	1	Double Crystal Si(111)	Cylinder Fused Quartz, Pt-coated	6 ~ 25	0.07x0.04		~ 2	
BL-20B [ANBF]	2	Channel Cut Si(111) Channel Cut Si(311) Sagittal Focusing Si(111) Double Crystal	None	4.5 ~ 21 10 ~ 36 4.5 ~ 25	25x2 25x1.5 0.6x1		~ 2 ~ 1 ~ 2	27
BL-27B	4	Double Crystal Si(111)	None	4 ~ 20	100x6		~ 2	28
AR-NE1A1	2	Double Bent Crystal Si(111) Si(400)		40 ~ 70 80 ~ 160	2x0.5	2×10^{13} (60 keV, 35mA)	8	29-31
AR-NE1A2	2.3	Asym. Cut Single Crystal Si(311)		33 ~ 38	95x120 ~140	10^{10} (33 keV)	60	
AR-NE3A	H:0.3 V:0.03	Double Crystal Si(111) High-Resolution Monochromator Nuclear Monochromator of Single Crystal ⁵⁷ Fe ₂ O ₃ (777)		5 ~ 25 8 ~ 26 14.4	15x2	1×10^3 (14.4 keV)	1 5×10^{-3} 1×10^{-7}	32
AR-NE5A	10	Asym.Cut Single Crystal Si(311), Si(511) ($\alpha = 4^\circ \sim 6^\circ$) Double Crystal Si(311), Si(111), Si(220)		20 ~ 60 20 ~ 100	150x80 100x3	5×10^8 (33.2 keV)	60 2	33, 34
AR-NE5C	3	Double Crystal Si(111)	None	30 ~ 100 or white	60x5		5	35

Branch Beamline	Horizontal Acceptance (mrad)	Type of Monochromator	Mirror	Photon Energy (keV)	Beam Size (HxV) (mm)	Photon Flux at Sample Position (/s)	Energy Resolution ($\Delta E/E \times 10^{-4}$)	Reference
AR-NW2A	H:1.0 V:0.2	Double Crystal Si(111) Liquid N ₂ Cooling	Bent Cylinder Si Rh-Coated	5 ~ 25	0.6x0.2	6x10 ¹²	~2	36-38
			Bent Flat Si Rh-Coated		~10x0.06			
AR-NW10A	1.2	Si(311)	Pt-Coated Bent Cylinder	8 ~ 42	2.2x0.5	1x10 ¹⁰	~1	39
AR-NW12A	H:0.3 V:0.1	Double Crystal Si(111) Liquid N ₂ cooling	Pre-Mirror Bent Flat Si Rh-Coated Post-Mirror Bent Cylinder Si Rh-Coated	6.5-17	1.3x0.3	2x10 ¹¹ (0.2x0.2 mm ²)	~2	
AR-NW14A [ERATO]	H:0.3 V:0.1	Double Crystal Si(111) Liquid N ₂ Cooling	Bent Cylinder Rh-Coated Bent Flat Rh-Coated	4.9 ~ 25	0.45x0.25	5x10 ¹²	~2	40

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Table 4 Specifications of VUV and soft X-ray beamline optics.

Beamline	Acceptance H × V (mrad) or Undulator Parameters	Type of Monochromator	Groove Density (ℓ/mm)	Energy Range (eV)	Beam Size H × V (mm)	Resolving Power (E/ΔE) Photon Flux (photons/s)	Reference
BL-1C	5 × 3	Varied-Line-Space Plane Grating	300 600 1200	20 ~ 60 40 ~ 120 80 ~ 240	1 × 1	1000 ~ 10000 10 ¹¹ ~ 10 ⁹	1
BL-2A Undulator	K = 0.5 ~ 2.2 λ_u = 6 cm	Double Crystal InSb (111), Si (111)	—	1740 ~ 5000	< 1φ	2000, 8000 10 ¹¹	2 - 5
BL-2C Undulator	K = 0.55 ~ 2.2 λ_u = 6 cm	Varied-Line-Space Plane Grating	1000 2200	250 ~ 1400	0.9 × 0.1	5000 ~ 10000 10 ¹¹ ~ 10 ¹⁰	6 - 8
BL-3B	10 × 2	Grazing Incidence R = 24 m $\alpha+\beta$ = 165°	200 600 1800	10 ~ 280	< 2φ	200 ~ 3000 10 ¹² ~ 10 ⁹	9, 10
BL-7A [RCS]	6 × 1	Varied-Line-Space Plane Grating	300 650	50 ~ 1300	2.5 × 0.5	1000 ~ 9000 10 ¹² ~ 10 ⁹	11
BL-7B [RCS]	6 × 4	1m Seya-Namioka	1200 2400	5 ~ 50	1 × 1	1000	12
BL-8A	0.5 × 1	SX700 Plane Grating	1221	38 ~ 2300	5 × 1	2000 10 ¹⁰	
BL-8B	3 × 0.5	Double Crystal InSb (111), Si (311)	—	1700 ~ 14000	1.9 × 0.5	5000	13
BL-11A	5 × 1	Varied-Line-Space Plane Grating	300 800 1200	70 ~ 1900	2 × 1	500 ~ 5000 10 ¹² ~ 10 ⁹	14 - 17
BL-11B	4 × 0.6	Double Crystal InSb (111), Ge (111)	—	1760 ~ 3910	5 × 2	2000 10 ¹⁰	4, 18, 19
BL-11C	4.8 × 3	1m Seya-Namioka	1200	4 ~ 35	~1φ	1000	20
BL-11D	4 × 2	Grazing Incidence Varied Deviation-angle On-Blaze Mount R ₁ = 52.5 m R ₃ = 22.5 m	2400	60 ~ 245 200 ~ 900	1 × 0.1	2000 10 ¹¹	21
BL-12A	2.2 × 0.34	Grazing Incidence R = 2 m α = 88°	1200	30 ~ 1000	2 × 3	1000 10 ⁹	22
BL-13C Undulator	K = 0.3 ~ 4.2 λ_u = 18 cm	Grazing Incidence R = 50 m $\alpha+\beta$ = 173.2°	350 750	70 ~ 500 150 ~ 1000	5 × 1	1000 ~ 6000 10 ¹² ~ 10 ¹⁰	23, 24
BL-16B Undulator	K = 0.5 ~ 5.75 λ_u = 12 cm	Grazing Incidence R = 24 m $\alpha+\beta$ = 168.6°	400 900 2000	40 ~ 550	< 1φ	1000 ~ 10000 10 ¹² ~ 10 ¹	25 - 27
BL-18A (ISSP)	2 × 2	Grazing Incidence R = 3 m $\alpha+\beta$ = 160° R = 6.65 m $\alpha+\beta$ = 167.5°	300 600 1200 500	15 ~ 150	< 1φ	1000 ~ 2000 10 ¹¹ ~ 10 ⁹	28

Beamline	Acceptance or H × V (mrad) Undulator Parameters	Type of Monochromator	Groove Density (ℓ/mm)	Energy Range (eV)	Beam Size H × V (mm)	Resolving Power (E/ΔE) Photon Flux (photons/s)	Reference
BL-19A Revolver Undulator (ISSP)	K = 1.0 ~ 9.0 $\lambda_u = 16.4$ cm K = 0.5 ~ 1.25 $\lambda_u = 5$ cm K = 0.5 ~ 2.5 $\lambda_u = 7.2$ cm K = 1.0 ~ 5.0 $\lambda_u = 10$ cm	Grazing Incidence R = 2 m $\alpha+\beta = 160^\circ$ R = 4 m $\alpha+\beta = 170^\circ$	600 1200 600 1200	12 ~ 250	< 0.7φ	1000 10^{12}	29, 30
BL-19B Revolver Undulator (ISSP)		Varied-Line-Space Plane Grating	800 2400	10 ~ 1200	< 0.5φ	400~4000 $10^{12} \sim 10^{11}$	30 - 32
BL-20A	28 × 5	3m Normal Incidence	1200 2400	5 ~ 40	2 × 1	300 ~ 30000 $10^{12} \sim 10^8$	33
BL-27A	5 × 0.5	Double Crystal InSb (111)	—	1800 ~ 4000		2000	34
BL-28A/B Helical Undulator	K _x = 0.23 ~ 3 K _y = 0.23 ~ 6 $\lambda_u = 16$ cm	Varied-Line-Space Plane Grating	400	30 ~ 300	0.15 × 0.05	30000 10^{12}	35
AR-NE1B Helical Undulator	K _x = 0.2 ~ 3 K _y = 0.2 ~ 6 $\lambda_u = 16$ cm	Grazing Incidence R = 10m $\beta = 89^\circ$	1200 2400	250 ~ 1600	~0.8 × 0.2	1000~5000 $10^{11} \sim 10^9$	36, 37

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